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NFORMATION DISCLOSURE STATEMENT

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Atty. Docket No. **METR:003**

Serial No. 10/668,642

Applicant

Dale A. Harrison

Filing Date:

Group:

September 23, 2003

Unknown Other Art

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		,L	J.S. Pate	ent Documents			
Exam. Init.	Ref. Des.	Document Number	Date	Name	Class	Sub Class	Filing Date if App.
Сн	A1	3,091,154	5/28/63	Hall	-		
CH	A2	4,899,055	2/6/90	Adams			
CH	A3	5,608,526	3/4/97	Piwonka-Corle et al.			
СН	A4	5,747,813	5/5/98	Norton et al.			
CH	A5	5,798,837	8/25/98	Aspnes et al.			
СН	A6	5,880,831	3/9/99	Buermann et al.			
CH	A7	5,900,939	5/4/99	Aspnes et al.		,	
СН	A8 .	5,991,022	4/27/99	Buermann et al.			
CH	A9	6,128,085	10/3/00	Buermann et al.	-		
CH	A10	6,181,427 BI	. 1/30/01	Yarussi, et al.			
CH	A11	6,278,519 Bl	8/21/01	Rosencwaig et al.	-		
CH	A12	6,297,880 BI	10/2/01	Rosencwaig et al.			
CH	A13	6,304,326 B	10/16/01	Aspnes et al.			
CH	A14	6,411,385 B2	6/25/02	Aspnes et al.			
CH	A15	6,414,302B	7/2/02	Freeouf			
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CH	A19	US2002/0149774	10/17/02	McAninch			
CH	A20	US2002/0154302	10/24/02	Rosencwaig etal.			
CH	A21	6,261,853 B	7/17/01	Howell et al.			
CH	A22	5,182,618	1/26/93	Heinonen			
CH	A23	3,572,951	3/30/71	Rothwarf et al.			
CH	A24	US2003/0071996	4/17/03	Wang et al.			

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U.S. Patent Documents See Page 1-2 Foreign Patent Documents See Page Other Art See Page 2-3

			U.S. Pat	tent Documents	. –		
Exam. Init.	Ref. Des.	Document Number	Date	Name	Class	Sub Class	Filing Date if App.
	A25	Unknown		"Vacuum Ultraviolet Optical System for Operation in Ambient Atmosphere" Inventors: Michael J. Mandella & Dale A. Harrison Filed: 9/10/99 (Prior filed US Patent Application – current status unknown)			9/10/99

Foreign Patent Documents									
Exam. Init.	Ref. Des.	Document Number	Date	Country	Class	Sub Class	Translation Yes/No		
	B1								

C	Other A	Art (Including Author, Title, Date, Pertinent Pages, Etc.)
Exam. Init.	Ref. Des.	Citation
	Cl	McPherson Product Brochure "Reflectometer for Sample Analysis," 3 pgs.
-	C2	McPherson Product Brochure "VUVaS Spectrophotometers for 115 nm to >380 nm," 4 pgs.
	C3	McPherson Product Brochure "VUVaS Spectrophotometers, Made to Measure 115-380 nm," 8 pgs.
	C4	Acton Research Product Brochure "Acton Research Purged DAMS Optical Measurement System," 2 pgs.
	, C5	"The Thin Film tool for next generation ithography at 157nm," Web page from http://www.sopra-sa.com , 1pg.
	C6	"SE and GXR combined on the same instrument," Web page from http://www.sopra-sa.com , lpg.

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Dale A. Harrison

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Other Art

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Other Art (Including Author, Title, Date, Pertinent Pages, Etc.)								
Exam. Init.	Ref. Des.	Citation						
_	C7	"The ideal Thin Film characterization unit for Development and Pilot Line environment," Web page from http://www.sopra-sa.com , 1 pg.						
	C8	"VUV-VASE TM, The Award Winning VUV-VASE TM is the latest addition to our line of Spectroscopic Ellipsometers," Web pages from http://www.jawoolam.com , 2 pgs.						
	C9	"Vacuum UV Spectroscopic Ellipsometers," Web pages from http://www.sentech.de, 3 pgs.						

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Atty. Docket No. **METR:003**

Serial No. 10/668,642

List of Patents and Publications for Applicant's

Applicant Dale A. Harrison

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Filing Date: September 23, 2003 Group: 2877

U.S. Patent Documents See Page 1

Foreign Patent Documents N/A

Other Art

See Page 1

		ι	J.S. Pat	ent Document	ts		
Exam. Init.	Ref. Des.	Document Number	Date	Name	Class	Sub Class	Filing Date if App.
C₩	A27	5,781,304	7/14/98	Kotidis et al.			2/14/97
CH	A28	2001/0055118A1	12/27/01	Nawracala			12/4/00
CH	A29	5,042,949	8/27/91	Greenberg et al.			3/17/89
CH	A30	3,825,347	7/23/74	Kaiser	-		8/9/71

Foreign Patent Documents								
Ref. Des.	Document Number	Date	Country	Class	Sub Class	Translation Yes/No		
		Ref. Document	Ref. Document Date	Ref. Document Date Country	Ref. Document Date Country Class	Ref. Document Date Country Class Sub		

Other Art (Including Author, Title, Date, Pertinent Pages, Etc.)								
Exam. Init.	Ref. Des.	Citation						
CH	C10	Search Report; PCT/US04/30859; 13 pgs. not a publication						

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